

Description

The present invention is related to integrated circuit radio frequency amplifiers. It is particularly related to a general purpose IC module which can be used as an IC "building block" to provide high quality RF amplification in a multitude of specific applications including high frequency (e.g. 1GHz) applications.

BACKGROUND OF THE INVENTION

A radio frequency amplifier has at least two principal functions. It must first amplify an input RF signal by an accurately known gain factor to produce a desired output level. Secondly, the input and output RF signals must be efficiently coupled into and out of the amplifier at the desired RF frequency (often over a broad band of frequencies) with little or no mismatch in RF impedances. For example, the output amplifier stage must efficiently couple an amplified r.f. signal to an RF load connected to its output terminals. The output stage must be capable of delivering the desired amount of RF signal power to the load with acceptably low levels of signal distortion if the amplifier is operated in a linear class (e.g., class A, class AB or class B). Moreover, the output stage should have a gain that is not greatly dependent upon load impedance. A well-designed RF output amplifier stage should achieve these performance specifications while consuming low quiescent power, providing stable operation under all expected input and output conditions, and without limiting the frequency response of the amplifier. Unfortunately, these (and perhaps other) well known desired performance specifications often can be difficult to simultaneously obtain from RF amplifier stages operated at very high frequencies (e.g., on the order of hundreds of MHz and in the GHz ranges).

In high-frequency RF communications equipment, considerable expense and circuitry has typically been necessary to design and construct intermediate amplifier stages which can develop sufficient power to drive high-power output stages. At high frequencies, stability problems become so severe that often per stage gains of only 5 to 8 dB are practical. The associated per stage band limiting components are generally expensive and consume precious space in modern RF communications equipment (miniaturization and minimization of which is usually desirable for a number of reasons).

Stability problems are primarily caused by uncertain amounts of reflected feedback impedance related to the effective capacitance of the active components in addition to layout-dependent stray capacitance. Furthermore, the feedback capacitance (commonly referred to as "Miller" capacitance) is one of the primary causes of changes in amplifier input impedance as load impedance varies with frequency.

Unavoidable capacitance between the collector and the base structures of a bipolar junction transistor (or between the source and the gate for a field-effect transistor) can cause a relatively large effective capacitance (the elemental component capacitance multiplied by 1 plus the voltage gain of the stage) to appear in parallel with the input to the transistor. The process by which the component capacitance is magnified and presented in parallel with the input terminals is often referred as the Miller effect. The Miller effect can reduce the unity-gain crossover frequency (gain-bandwidth product) of a transistor amplifier substantially if the amplifier is not well-designed. Because the amount of Miller feedback capacitance is related to stage gain, such feedback capacitance increases as the stage gain increases. In the case of a tuned load, this effective input capacitance typically can vary widely. In a production environment, these uncertain capacitances vary from one lot of amplifiers to another, often requiring expensive and critical manual tuning and/or manual "trimming" of passive components.

An additional need to conserve DC power exists whenever an amplifier stage is to be used in battery-operated equipment. Excess DC current is typically required so as to set the DC bias current of an RF amplifier stage at an appropriate level to insure a desired RF output power. (Such excess current is, for example, sometimes required to overcome biasing changes caused by expected transistor gain variations between different units in a large scale manufacturing environment.) Unfortunately, such excess current, when drawn from a battery power supply, can seriously shorten the life of the power supply, thereby reducing equipment reliability and increasing equipment maintenance costs.

FIGURE 1 is a schematic diagram of one commonly-used prior art discrete high-frequency power amplifier 10. An input signal is coupled to amplifier 10 via a coupling capacitor 12 and a matching network 14 (the purpose of which is to match the input impedance of the amplifier with the impedance of the signal source and thereby obtain more efficient signal transfer). The RF output of amplifier 10 is coupled from the collector of transistor 20 to a load 16 via another coupling capacitor 18. Amplifier 10 typically includes a bipolar junction transistor 20 connected in the common-emitter configuration, a radio frequency (RF) choke 22 (L1), bias voltage divider resistors 24 and 26, and an RF bypass capacitor 28. Supply voltage V_{cc} is connected to the collector of transistor 20 via RF choke 22 which, together with bypass capacitor 28,

prevent significant RF energy from reaching the power supply.

While the circuit configuration shown in FIGURE 1 is extremely useful in a wide variety of different applications, it also has a lot of disadvantages -- all of which become more critical as operating frequency increases and/or as the desired frequency band of operation is broadened. The input and output capacitance of amplifier 10 may be unacceptably high due to the Miller effect discussed above. Moreover, input and output capacitance may vary widely with amplifier instantaneous gain, load, signal level and frequency. There is a trade-off in amplifier 10 between stability and high gain which seriously limits the maximum power gain that can be expected. Moreover, implementation of amplifier 10 in an integrated circuit environment poses still further problems, since wire bonding inductance can become critical at high power levels and result in higher packaging costs. An integrated circuit implementation of amplifier 10 typically also requires the back surface of the integrated circuit chip to be tied to the output terminal, and thus requires ground isolation techniques to be used in the "packaging" of the IC chip.

Other high-frequency amplifier circuits exist which are better adapted for implementation in an integrated circuit format. For instance, United States Patent No. 4,240,041 to Hashimoto et al (1980) discloses a high-frequency amplifier circuit capable of being integrated onto a single semiconductor chip. The output transistor of the amplifier disclosed may be operated in class AB, B or C by setting circuit parameters as desired. Moreover, the amplifier disclosed in this reference can be placed on a chip having relatively few (5) leads. However, the disclosed amplifier circuit uses double inversion (i.e., the output voltage is of the same polarity as the input voltage), thereby creating the possibility that positive feedback from the output to the input terminal may cause instability at high frequencies. Moreover, the amplifier gain is a complex function of the biasing resistance and the relative areas and transconductances of the various transistors used in the circuit. Finally, the biasing resistance must be relatively small to mask expected variations in transistor gains, thus causing power to be wasted.

Other examples of prior art possibly relevant to the present invention include (and there may be many more):

U.S. Patent No. 3,392,342 to Ordower	(1968);
U.S. Patent No. 3,626,313 to Zuk	(1971);
U.S. Patent No. Re.30,297 to Wittlinger	(1980);
U.S. Patent No. 3,992,676 to Knight	(1976);
U.S. Patent No. 3,942,129 to Hall	(1976);
U.S. Patent No. 3,950,708 to Hall	(1976);
U.S. Patent No. 3,952,257 to Schade, Jr.	(1976);
U.S. Patent No. 4,028,631 to Ahmed	(1977);
U.S. Patent No. 4,140,977 to Ahmed	(1979);
U.S. Patent No. 4,237,414 to Stein	(1980);
and	
U.S. Patent No. 4,242,643 to Leidich	(1980).

The patents listed above disclose various bipolar junction transistor configurations which can be used in high-frequency amplifier applications. For instance, Patent No. 3,392,342 to Ordower discloses current mirror biasing. Zuk teaches a current mirror amplifier employing scaled geometries for the input and output transistors and using a cascaded output arrangement. Wittlinger teaches a current mirror amplifier which maintains collector potentials of the input and output transistors at equal levels. Knight shows a current mirror amplifier similar to Wittlinger's with a self-biased cascaded output stage. Ahmed '631 teaches a current mirror amplifier having a collector-base shunted input biasing resistor used to reduce input impedance.

Despite the recent advantages in integrated circuit technology, and despite the existence of a multitude of prior art circuits such as those identified above, no monolithic (i.e. integrated circuit) RF amplifier building blocks previously have been developed which can provide truly accurate and relatively high gain and power levels over a very wide band of high RF frequencies while yet permitting accurate control of DC output current for a given DC input current and minimizing the DC input power for a given RF output power. Moreover, most integrated-circuit high-frequency amplifier stages which have been proposed have significant high-frequency stability problems due to excessive input capacitance which changes over a large range with changing load impedance. Critical factor trim of individual components due to capacitance variations in active amplifier elements typically has been necessary, in the past, to obtain desired gain factors, and cascaded stages are typically needed to drive RF power devices or modules even when such

trimming techniques are employed. No integrated circuit building block has previously been available which solves all of these problems at low cost and low complexity. Such a building block, if available, could be used in a variety of RF communications equipment product lines including mobile, cellular and hand-held battery communications equipment. If such a building block were capable of achieving stability at high efficiency, it would be ideal for use in a wide variety of different applications in such equipment, such as for RF preamplification, RF power drivers, RF power modules, and receiver mixers or IF amplifiers.

According to the present invention, there is provided an RF amplifier for amplifying signals in excess of 100 MHz, said amplifier comprising:

a voltage RF amplifying transistor for producing an RF voltage across an output thereof proportional to an input RF current applied in series with said output;

a single current RF amplifier transistor having only a single transistor amplifier stage with an output operatively coupled in series with the output of the voltage amplifier transistor and connected to current gain amplify an input RF signal thereto, for controlling the current applied to said voltage RF amplifier transistor in response to the input RF signal thereby providing a current and voltage gain amplifier RF signal across the collective series-connected outputs of said amplifying transistors having a frequency in excess of 100 MHz; and

biasing means connected to each of said amplifying transistors and to a common DC bias input for establishing quiescent biasing current within each of the voltage and current amplifying transistors which is substantially independent of signal level;

said biasing means including at least a first transistor; and

said current RF amplifier transistor being connected in a current mirror configuration with said first transistor;

wherein said biasing means further includes at least one diode and a resistor connected in series with said first transistor to supply bias current thereto such that the bias current supplied to said current RF amplifier transistor by said biasing means is sufficient to raise the collector to base potential of said current amplifier transistor so much above zero as to ensure operation at frequencies in excess of 100 MHz.

Embodiments of the present invention therefore provide a high-frequency integrated circuit RF amplifier which provides an accurate and high gain over a wide band of RF frequencies, uses DC input power very efficiently, is stable at even very high RF frequencies (i.e. beyond 1 GHz) and has significantly reduced input capacitance which is largely independent of load impedance. In very brief summary the new amplifier module includes two cascaded stages of amplification --current gain followed by voltage gain. The input current gain stage is biased by a current mirror arrangement which is in turn, fed by a forward-biased diode (e.g. a shorted collector-base transistor) having a stable voltage drop thereacross. The diode provides temperature compensation while also maintaining a relatively low voltage across the current-gain stage and thus minimizing the voltage swing across the cascaded voltage-gain stage.

An amplifier in accordance with the present invention may simply include four transistors, preferably fabricated on the same semiconductor wafer. Only four externally accessible leads (i.e. IC "pads") need be provided to provide full external access to the amplifier chip (although plural pads may be provided in parallel connections to some of the four terminal points so as to minimize inductance and/or to maximize conductance of wire bonds). Because only four connections to the external world are required, the entire module can be very advantageously "packaged" in a conventional four-leaded "Micro-X" IC package/carrier.

First and second transistors (Q1 and Q2) are preferably connected together in a current mirror configuration. (That is, the emitter areas of the first and second transistors are scaled and the electrodes are interconnected so that the current flowing through the second transistor Q2 is a multiple of the current flowing through the first transistor Q1). The first current-mirror transistor Q1 acts to bias the second transistor Q2. A third transistor Q3 (preferably a collector-base shorted diode) feeds DC bias supply to the current mirror coupled first and second transistors and also provides an accurate voltage drop to ensure that the second transistor Q2 (the current gain stage) properly operates in its active region (i.e., is not saturated). The second transistor Q2 (common-emitter current gain) and a fourth transistor Q4 (common-base to provide voltage gain) are connected together in a cascade configuration and the voltage drop across the Q3 diode also tends to minimize collector-emitter voltage swings across Q2 while maximizing collector-emitter voltage swings across Q4.

As noted, the second transistor Q2 provides current gain, while the fourth transistor Q4 provides voltage gain. The instantaneous current flowing through the fourth transistor Q4 is a function of the current flowing through the second transistor Q2. The quiescent operating points of both amplifying transistor stages can be simultaneously controlled via a common bias terminal. Hence, the power of the output signal produced by the amplifier is directly controlled by the input signal level, with a very accurate gain relationship

established by the scaled geometries of the first and second transistors Q1 and Q2 (i.e. the current mirror). A relatively high breakdown voltage is established across the fourth transistor Q4 due to the cascade connection with a current gain stage Q2. Moreover, very little load capacitance is reflected from the RF load back to the input of the fourth transistor Q4, providing a relatively low input capacitance which does not vary much with load impedance.

Because the amplifier in accordance with embodiments of the invention may be an inverting amplifier (even though it uses two cascaded gain stages), there is significantly reduced possibility that output-to-input signal feedback can cause oscillation.

Output stage DC current is tightly controlled by the input biasing current, so that power control is obtained without sacrificing efficiency. Extremely broadbanded operation at relatively high, accurate gains can be obtained (e.g. 15 dB of gain at 900 MHz changing smoothly to 25 dB of gain at 100 MHz).

Because of the uniquely advantageous combination of high quality performance characteristics, simplicity and low cost of an IC amplifier constructed in accordance with the present invention, it is anticipated that the amplifier will find wide use as a "building block" in many different applications including but not limited to RF communications circuits.

BRIEF DESCRIPTION OF THE DRAWINGS

These and other objects and advantage of the present invention will be better understood by carefully reading the following detailed description of the presently preferred exemplary embodiments of this invention taken in conjunction with the accompanying drawings of which:

Figure 1 is a schematic diagram of one typical type of prior-art high-frequency RF radio frequency amplifier;

FIGURE 2 is a schematic diagram of a first exemplary embodiment of an integrated circuit RF amplifier in accordance with the present invention;

FIGURE 3 is a schematic diagram of a second exemplary embodiment of the present invention modified to further reduce input loading effects;

FIGURE 4 is a top view (e.g. a computer generated overlay drawing of the IC masks) of an exemplary layout of an integrated circuit chip which may be utilized to realize the embodiment of FIGURE 2 (resistance 54 is included within the structure of transistor Q3 in this embodiment);

FIGURES 5A, 5B and 5C are, respectively, a schematic circuit diagram, a general top view of an IC chip layout and an exploded top view of the center thereof for an exemplary 10 milliwatt version of the FIGURE 3 embodiment;

FIGURES 6A, 6B and 6C correspond to FIGURES 5A-5C respectively but for an exemplary 50 milliwatt version of the FIGURE 3 embodiment;

FIGURES 7A, 7B and 7C also correspond to FIGURES 5A-5C respectively but for an exemplary 150 milliwatt version of the FIGURE 3 embodiment;

FIGURE 8 is a plot of typical power output for various input power levels of the new amplifier over a 100 MHz to 800 MHz frequency range; and

FIGURE 9 is a plot of typical operating efficiency of the new amplifier for various applied bias currents over a frequency range of 400 MHz to 500 MHz.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

FIGURE 2 is a schematic diagram of a first exemplary embodiment of the new amplifier 50. The active components of amplifier 50 may be fabricated on a single integrated circuit semiconductor wafer 52 (using conventional integrated circuit layout and construction techniques) and connected to external circuitry by only four terminals (i.e. IC "pads") A-D. In the preferred embodiment, terminal A is a grounding lead, terminal B is an input lead, terminal C is an output lead and terminal D is a biasing lead. Because of the small number of leads required to connect the components fabricated on wafer 52 with external components, amplifier 50 can be produced using a small conventional 4-leaded IC chip package (e.g. a "Micro-X" package carrier). One possible chip layout is illustrated in FIGURE 4.

Four transistors Q1, Q2, Q3 and Q4 are fabricated on wafer 52 in the preferred embodiment. Although all of the transistors shown in FIGURE 2 are NPN bipolar junction transistors, PNP bipolar junction transistors or field effect transistors (FET) could be used instead (in the latter instance, base-collector-emitter structures become gate-drain-source FET structures as will be appreciated). In FIGURE 2, the emitter of Q1 is connected to ground terminal A, while the base of Q1 is connected to its collector. The emitter of Q2 is connected to ground terminal A, while the base of Q2 is connected to the base (and hence

also to the collector) of Q1. Input terminal B is connected to the commonly-connected base of Q2 and to the base and collector of Q1.

The collector of Q1 is connected through an emitter resistor 54 (which preferably is fabricated by diffusion or by some other conventional method and/or may be included as a part of the transistor Q3 structure on wafer 52 by purposefully making a lossy junction electrode lead structures) to the emitter of Q3. The collector of Q3 is connected to its own base, so that Q3 functions as a collector-base shorted diode. The bases of Q3 and Q4 are both connected to the DC biasing input terminal D. The emitter of Q4 is connected to the collector of Q2, while the collector of Q4 is connected to the RF output terminal C.

In a typical application, an RF signal source 56 is coupled to input terminal B through coupling capacitor 58 and a conventional matching network 60. Coupling capacitor 58 serves to prevent DC levels from being coupled between input terminal B and source 56, while matching network 60 matches the input impedance of source 56 to the input impedance appearing at input terminal B. An RF load 62 is connected to output terminal C through a series-connected coupling capacitor 64. An RF choke 66 is connected in series between output terminal C and a power supply voltage V_{cc} to block RF energy from flowing to the power supply. A bypass capacitor 68 is connected between V_{cc} and ground potential to provide an RF ground. A biasing resistor 70 is connected between V_{cc} and biasing terminal D. Alternatively, a controlled bias current source may be directly connected to supply terminal D. A relatively-large bypass capacitor 72 connected between biasing terminal D and ground potential ensures that the biasing terminal D is at RF ground potential. Grounding terminal A is connected directly to DC and RF ground potential.

Transistors Q1 and Q2 have scaled geometries to provide an accurate relationship between the input DC bias current and the DC current in the output amplifier stages Q2, Q4. For example, if the emitter of transistor Q1 is made to have a relative size of 10x and the emitter of Q2 is made to have a relative size of 100x, the multiplied current $M \cdot I_{bias}$ flowing through transistor Q2 will be very nearly 10 times the DC input bias current I_{bias} flowing through transistors Q3 and Q1 (and thus, M is equal to 10). This direct "current mirror" relationship (well known in and of itself) between current in transistor Q2 and biasing current increases the overall efficiency of amplifier 50 and also permits direct control of the amplifier RF power output. For example, the quiescent operating point of amplifier 50 can be varied by simply selecting the value of biasing resistor 70 (or current source). If biasing resistor 70 has a relatively small resistance, amplifier 50 will operate in the linear class A or B mode. On the other hand, amplifier 50 can be set to operate in a class C mode (i.e., where load current is cut off except during input signal peaks) by setting the resistance of biasing resistor 70 to a relatively large value. In this way, efficiency and desired class of amplifier operation can easily be adjusted to suit different applications.

The shorted collector-base junction of Q3 may provide a very low input impedance to the source 56. This is because biasing terminal D is at RF ground (due to the effect of external bypass capacitor 72) and because the collector-base shorted Q3 appears almost as a short circuit to the input source (i.e. the "diode" Q3 is forward-biased to an "on" condition during operation). This very low input impedance also ensures that current gain transistor Q2, in effect, is driven by a low impedance source, causing only a very small voltage swing to be present on the collector of Q2 (and thus yielding very low feedback or "Miller" capacitance to input terminal B). Resistor 54 is provided merely to reduce the loading losses associated with the presence of transistor Q3 (and may in the exemplary embodiment have a value on the order of 30 to 100 ohms).

Transistor (diode) Q3 also serves to bias the collector voltage of transistor Q2 to a value very near ground potential in order to maximize the output voltage swing at the collector of Q4. By maximizing output voltage swing at Q4, the overall output power of amplifier 50 is maximized for a given amount of input DC power, making the amplifier more efficient. Efficiency is especially important if amplifier 50 is provided with power supply voltage V_{cc} from a battery-operated power supply.

Because the base of Q4 is also at RF ground potential (due to external bypass capacitor 72), the RF load impedance seen by the collector of current gain stage Q2 is extremely low. Hence, any changing capacitance reflected to the base of Q4 by the Miller effect (e.g. as a result of a changing load impedance 62) will not be reflected further to the base of Q2. As a result, only extremely low Miller capacitance is reflected to input terminal B.

The input impedance of Q4 is itself very low because it is connected in a common-base configuration. Moreover, transistors Q2 and Q4 are connected in a cascode arrangement so that very high output impedance is presented to output terminal C in order to achieve large amounts of voltage gain from transistor Q4. The cascode arrangement (i.e. current-gain amplifier Q2 feeding voltage-gain amplifier Q4) also results in much lower reflection of variations in the impedance of load 62 to the base of transistor Q4 as well as a higher breakdown voltage across the RF output terminals of the module (which may be useful if load 62 is a tuned circuit, an impedance which is mismatched with the output impedance of amplifier 50,

etc.).

An additional power-saving feature of amplifier 50 is derived from the peak rectification action that exists at input terminal B. As the signal produced by source 56 increases, a DC bias voltage is built up across coupling capacitor 58 (or an equivalent capacitance internal to matching network 60) resulting from the rectification action at the base of transistor Q1. This DC bias causes the DC bias current in the output stages Q2 and Q4 to decrease, which thereby increases the efficiency (i.e. the ratio of output RF power to DC input power). By carefully selecting component values, the overall output RF power of amplifier 50 can be made to approach the maximum theoretical value for a given amount of DC input power.

Amplifier 50 is, overall, an inverting amplifier (i.e., a voltage increase at input terminal B causes an voltage decrease at output terminal C). This results because although the common-emitter first stage Q2 inverts, the cascaded common-base second stage Q4 does not. Hence, there is no possibility that positive feedback can occur from output terminal C to input terminal B to cause amplifier 50 to oscillate. Any feedback between output terminal C and input terminal B may decrease amplifier gain somewhat (since this feedback is negative or degenerative feedback), but will enhance rather than decrease the stability of the amplifier.

Amplifier 50 has relatively good temperature stability because transistors Q1-Q4 are all preferably fabricated on the same wafer 52 using similar fabrication techniques. Any temperature change affecting one of the transistors will also affect the other three in the same manner (since each of the elements have the same temperature coefficient). In some instances, biasing resistor 70 may change in resistance with changes in temperature. Also, the base-to-emitter voltage drops across Q1 and Q2 may change somewhat with temperature. However, it has been found that these factors only change the value of I_{bias} by a relatively small amount, so that excellent temperature stability is obtained without requiring extraordinary measures to reduce the temperature change of wafer 52.

Although bipolar NPN transistors are typically constructed with an N-type starting material, I prefer to use a P-type starting material and implant an N-type pocket therein to act as the collector electrode. In this manner, the back of the IC wafer may be directly grounded to simplify the IC packaging and permit improved thermal contact with the IC carrier.

FIGURE 3 is a schematic diagram of another further improved (and therefore presently preferred) embodiment of the present invention. The embodiment shown in FIGURE 3 is identical in all respects with the embodiment shown in FIGURE 2 except that resistors 74 (R2) and 76 (R1) have been added. Resistor 74 is connected between the base of Q1 and its own collector (so that Q1 no longer has its base directly shorted to its collector). Resistor 76 is connected between the base of Q2 and the collector of Q1. Resistors 74 and 76 serve the dual purposes of (1) better isolating the amplifier from input source 56 and (2) maintaining the desired current mirror matching of transistors Q2 and Q1 even though such improved isolation has been provided.

In the embodiment shown in FIGURE 2, input terminal B is coupled to the emitter of Q3 through resistor 54 (labeled R3 in FIGURE 3). Q3 operates as a forward biased collector-base shorted diode, and thus appears as a near short-circuit to an RF signal applied to input terminal B. The commonly-connected base and collector of Q3 are tied to RF ground (through bypass capacitor 72) at the biasing terminal D. Unless some isolation is provided between input terminal B and the emitter of transistor Q3, excessive loading of the input signal applied to input terminal B may occur under some circumstances.

Resistor 54 (which may be a conventional diffusion-type integrated circuit resistor, or may be conventionally built into the structure of transistor Q3) reduces some of the loading losses associated with the presence of transistor Q3. However, a further resistor 76 may be connected (as shown in FIGURE 3) in series between input terminal B and the emitter of transistor Q3 to still further reduce such loading losses and thus even better isolate the input terminal. In effect, the presence of resistor 76 prevents too much input RF power from flowing into collector-base shorted diode Q3 and thus minimizes source loading and permits more efficient use of the RF current applied to input terminal B (as most of this current will now flow as useful RF input to transistor Q2).

As will be recalled, Q1 and Q2 are geometrically scaled in a current mirror configuration, and thus are current matched at a desired ratio. Resistor 74 therefore is added to preserve this current matching. The value of resistor 76 is chosen as desired to provide sufficient input isolation. As will be recalled, the area of transistor Q2 is M times the area of transistor Q1. The value of resistor 74 is thus chosen to be M times the value of resistor 76 to preserve the scaled current-matched relationship between transistors Q1 and Q2. Assuming $\beta_{Q1} = \beta_{Q2}$ (which is generally the case, since these two transistors are fabricated on the same substrate and operate at the same current density), the base current of Q2 is M times larger than the base current of Q1. If resistor 74 is made to be M times larger than resistor 76, the voltage drops across resistors 74 and 76 are the same. In the general case, the resistance of resistor 74 is made to be N times larger than

the resistance of resistor 76, where N is the ratio of the area of transistor Q2 to the area of transistor Q1 on the IC chip layout so as to preserve current matching between transistors Q2 and Q1.

The exemplary FIGURE 3 embodiment is illustrated for three specific maximum power levels at FIGURES 5A-5C (10 milliwatts), FIGURES 6A-6C (50 milliwatts) and FIGURES 7A-7C (150 milliwatts). The redrawn schematic diagrams of FIGURES 5A, 6A and 7A include exemplary component values and illustrate extra parallel-connected IC pad connection terminals for the external ground and bias connection points A and D. FIGURES 5B, 6B and 7B provide an overview of an exemplary chip layout at a first scale where the various IC pads are clearly apparent. The central "working" portion of each IC chip layout is shown at enlarged scale at FIGURES 5C, 6C and 7C. Since conventional IC fabrication processes can be employed, no further detail need be given.

Typical output power curves for frequencies from 100 MHz to 800 MHz for various input power levels are depicted at FIGURE 8. FIGURE 9 shows typical output power curves (and efficiency) from 400 MHz to 500 MHz for various bias currents. Typical measured input and output impedances over a frequency range from 50 MHz to 860 MHz are presented in Table 1 below:

TABLE 1

FREQ. (MHz)	INPUT Z		OUTPUT Z	
	R	jx	R	jx
50	46	-j38 (83p)	64	-j8.3 (380p)
130	34	-j24 (51p)	51	-j25 (49p)
180	25	-j27 (32p)	42	-j22 (41p)
400	11	-j11 (36p)	50	-j20 (20p)
512	14.8	+j0.4 (.1 nH)	23	-j22 (14p)
860	13.2	+j1.2 (.2 nH)	32	-j35 (5.3p)

The new RF amplifier module can now be appreciated as being capable of providing some or all of the following potentially desired characteristics:

- * An IC chip which can be fit, if desired, into a 4 leaded microwave package
- * The back of the IC chip may be directly tied to ground potential thus improving thermal coupling and simultaneously simplifying IC packaging
- * Multiple ground and bias IC pads may be added to ease wire bonding inductance/conductance problems
- * Good bias control via a simple external circuit is provided for easily achieving Class A, B or C amplifier operation
- * Power level control is also obtained via the same simple bias control and via the same external bias lead connection point
- * Input & output capacitance is lowered (less Miller capacitance)
- * Input & output capacitance is not so heavily related to gain, load, signal level or frequency (controllable by device design)
- * High and stable gain factors (e.g. 15 dB gain at 960 MHz compared to only 5 dB gain for a typical discrete component design)

While only a few embodiments of the present invention have been described in detail above, additional and alternate embodiments and implementation schemes now will be evident to those of ordinary skill in the art. For example, although all of the transistors described are NPN transistors, PNP bipolar junction transistors or field effect transistors (such as gallium arsenide active elements) could be substituted instead. Moreover, in some circumstances, direct connections or other types of circuit elements could be substituted for resistors 74, 76 or 54 if desired. It might be desirable to add additional collector-shortcd diodes in series with the one formed by transistor Q3 in order to permit the use of higher supply voltages V_{cc} while still maintaining the capacitance of transistor Q2 at an acceptably low level. As will be readily appreciated, one or more two-terminal elements (i.e. PN junction diodes) could be substituted for at least transistor Q3. While transistors Q1 and Q2 should be fabricated on the same wafer to obtain the current matching described, the other circuit elements, if desired, need not necessarily be included on the same wafer and might thus be discrete external elements for some applications. And additional transistor structures might be added (e.g. connected in parallel to some of those shown in the exemplary embodiments to get higher power capability). Accordingly, these and all such other alternatives which continue to realize at least some of the

novel features of this invention are to be considered within the scope of at least the broader ones of the following claims.

Claims

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1. An RF amplifier (50) for amplifying signals in excess of 100 MHz, said amplifier comprising:
 - a voltage RF amplifying transistor (Q4) for producing an RF voltage across an output thereof proportional to an input RF current applied in series with said output;
 - a single current RF amplifier transistor (Q2) having only a single transistor amplifier stage with an output operatively coupled in series with the output of the voltage amplifier transistor (Q4) and connected to current gain amplify an input RF signal thereto, for controlling the current applied to said voltage RF amplifier transistor (Q4) in response to the input RF signal thereby providing a current and voltage gain amplifier RF signal across the collective series-connected outputs of said amplifying transistors having a frequency in excess of 100 MHz; and
 - biasing means connected to each of said amplifying transistors and to a common DC bias input for establishing quiescent biasing current within each of the voltage and current amplifying transistors which is substantially independent of signal level;
 - said biasing means including at least a first transistor (Q1); and
 - said current RF amplifier transistor (Q2) being connected in a current mirror configuration with said first transistor (Q1);
 - wherein said biasing means further includes at least one diode (Q3) and a resistor (54,R3) connected in series with said first transistor (Q1) to supply bias current thereto such that the bias current supplied to said current RF amplifier transistor (Q2) by said biasing means is sufficient to raise the collector to base potential of said current amplifier transistor so much above zero as to ensure operation at frequencies in excess of 100 MHz.
2. An RF amplifier as in claim 1 wherein said diode comprises a transistor (Q3) including a base coupled to the collector at a junction which is connected to said common DC bias input, said junction also being directly connected to said voltage RF amplifying transistor (Q4).
3. An RF amplifier as in claim 1 wherein said first and said current RF amplifying transistors (Q1,Q2) have geometrically scaled structures to establish current multiplication ratio 1:M therebetween and further comprising a decoupling resistance (74) and a matching resistance (76) included within said current mirror configuration, the ratio between said decoupling and matching resistances being M:1 so as to maintain the 1:M DC current ratio between said first and current RF amplifying transistors in the presence of said decoupling resistance.
4. An RF amplifier as in claim 1 wherein said voltage and current RF amplifying transistors collectively provide an output AC signal which is inverted or approximately 180° out of phase with respect to an input AC signal.
5. An RF amplifier as in claims 1, 2, 3 or 4 wherein said amplifier is a monolithic integrated circuit fabricated from a P-type semiconductor substrate starting material.
6. An RF amplifier as in claims 1, 2, 3 or 4 wherein said amplifier is a monolithic integrated circuit and each of said transistors are bipolar NPN transistors fabricated within the same monolithic integrated circuit wafer.
7. An RF amplifier as in claims 1, 2, 3 or 4 further comprising:
 - an input signal terminal (B);
 - an output signal terminal (C);
 - a DC bias input terminal (D);
 - a ground reference terminal (A);
 - wherein said amplifier is a monolithic integrated circuit and each of said transistors are bipolar NPN transistors fabricated within the same monolithic integrated circuit wafer; and
 - wherein said integrated circuit wafer includes at least one electrical connection pad to serve as each of said terminals and wherein at least one of said terminals comprises a plurality of such pads electrically connected in parallel.

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8. An RF amplifier as in claims 1, 2, 3, or 4 further comprising:

an input signal terminal (B);

an output signal terminal (C);

a DC bias input terminal (D);

a ground reference terminal (A);

wherein said amplifier is a monolithic integrated circuit and each of said transistors are bipolar NPN transistors fabricated within the same monolithic integrated circuit wafer;

wherein said integrated circuit wafer includes at least one electrical connection pad to serve as each of said terminals and wherein at least one of said terminals comprises a plurality of such pads electrically connected in parallel; and

wherein said amplifier is packaged within a four leaded Micro-X-integrated circuit package providing only four external electrical connection points.

Revendications

1. Un amplificateur radiofréquence (50) pour l'amplification de signaux de plus de 100 MHz, ledit amplificateur comprenant :

un transistor amplificateur de tension radiofréquence (Q4) destiné à fournir aux bornes d'une sortie de celui-ci une tension radiofréquence proportionnelle à un courant radiofréquence d'entrée appliqué en série avec ladite sortie ;

un transistor amplificateur de courant radiofréquence individuel (Q2) ne comportant qu'un seul étage amplificateur à transistor avec une sortie fonctionnellement couplée en série avec la sortie du transistor amplificateur de tension (Q4) et connecté de manière à amplifier avec gain en courant un signal radiofréquence d'entrée qui lui est appliqué, pour commander le courant appliqué audit transistor amplificateur de tension radiofréquence (Q4) en réponse au signal radiofréquence d'entrée, en fournissant ainsi aux bornes des sorties collectives connectées en série desdits transistors amplificateurs un signal radiofréquence amplifié avec gain en courant et en tension ayant une fréquence dépassant 100 MHz ; et

des moyens de polarisation connectés à chacun desdits transistors amplificateurs et à une entrée de polarisation continue commune pour établir au sein de chacun des transistors amplificateurs de tension et de courant un courant de polarisation de repos qui est sensiblement indépendant du niveau de signal ;

lesdits moyens de polarisation comportant au moins un premier transistor (Q1); et

ledit transistor amplificateur de courant radiofréquence (Q2) étant monté dans une configuration en miroir de courant avec ledit premier transistor (Q1) ;

dans lequel lesdits moyen de polarisation comportent outre au moins une diode (Q3) et une résistance (54, R3) montées en série avec ledit premier transistor (Q1) pour appliquer à celui-ci un courant de polarisation tel que le courant de polarisation appliqué audit transistor amplificateur de courant radiofréquence (Q2) par lesdits moyens de polarisation soit suffisant pour faire monter le potentiel collecteur-base dudit transistor amplificateur de courant assez haut au-dessus de zéro pour assurer un fonctionnement à des fréquences dépassant 100 MHz.

2. Un amplificateur radiofréquence selon la revendication 1, dans lequel ladite diode comprend un transistor (Q3) à base couplée au collecteur en une jonction qui est reliée à ladite entrée de polarisation continue commune, ladite jonction était aussi reliée directement audit transistor amplificateur de tension radiofréquence (Q4).

3. Un amplificateur radiofréquence selon la revendication 1, dans lequel ledit premier transistor (Q1) et ledit transistor amplificateur de courant radiofréquence (Q2) ont des structures géométriquement proportionnées pour établir un rapport de multiplication de courant 1:M entre eux, et comprenant en outre une résistance de découplage (74) et une résistance d'adaptation (76) faisant partie de ladite configuration en miroir de courant, le rapport entre lesdites résistances de découplage et d'adaptation étant M:1 pour assurer le maintien du rapport de courants continus 1:M entre lesdits premier et deuxième transistors amplificateurs de courant radiofréquence en présence de ladite résistance de découplage.

4. Un amplificateur radiofréquence selon la revendication 1, dans lequel lesdits transistors amplificateurs de tension et de courant radiofréquence fournissent collectivement un signal alternatif de sortie qui est

8. An RF amplifier as in claims 1, 2, 3, or 4 further comprising:

- an input signal terminal (B);
- an output signal terminal (C);
- a DC bias input terminal (D);
- a ground reference terminal (A);

wherein said amplifier is a monolithic integrated circuit and each of said transistors are bipolar NPN transistors fabricated within the same monolithic integrated circuit wafer;

wherein said integrated circuit wafer includes at least one electrical connection pad to serve as each of said terminals and wherein at least one of said terminals comprises a plurality of such pads electrically connected in parallel; and

wherein said amplifier is packaged within a four leaded Micro-X-integrated circuit package providing only four external electrical connection points.

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des moyens de polarisation connectés à chacun desdits transistors amplificateurs et à une entrée de polarisation continue commune pour établir au sein de chacun des transistors amplificateurs de tension et de courant un courant de polarisation de repos qui est sensiblement indépendant du niveau de signal ;

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2. Un amplificateur radiofréquence selon la revendication 1, dans lequel ladite diode comprend un transistor (Q3) à base couplée au collecteur en une jonction qui est reliée à ladite entrée de polarisation continue commune, ladite jonction étant aussi reliée directement audit transistor amplificateur de tension radiofréquence (Q4).

3. Un amplificateur radiofréquence selon la revendication 1, dans lequel ledit premier transistor (Q1) et ledit transistor amplificateur de courant radiofréquence (Q2) ont des structures géométriquement proportionnées pour établir un rapport de multiplication de courant 1:M entre eux, et comprenant en outre une résistance de découplage (74) et une résistance d'adaptation (76) faisant partie de ladite configuration en miroir de courant, le rapport entre lesdites résistances de découplage et d'adaptation étant M:1 pour assurer le maintien du rapport de courants continus 1:M entre lesdits premier et deuxième transistors amplificateurs de courant radiofréquence en présence de ladite résistance de découplage.

4. Un amplificateur radiofréquence selon la revendication 1, dans lequel lesdits transistors amplificateurs de tension et de courant radiofréquence fournissent collectivement un signal alternatif de sortie qui est



inversé ou déphasé d'à peu près 180° par rapport à un signal alternatif d'entrée.

5. Un amplificateur radiofréquence selon les revendications 1, 2, 3 ou 4, dans lequel ledit amplificateur est un circuit intégré monolithique réalisé à partir d'un matériau de départ de substrat semiconducteur de type P.
6. Un amplificateur radiofréquence selon les revendications 1, 2, 3 ou 4, dans lequel ledit amplificateur est un circuit intégré monolithique et chacun desdits transistors est un transistor bipolaire NPN formé au sein de la même tranche de circuit intégré monolithique.
7. Un amplificateur radiofréquence selon les revendications 1, 2, 3 ou 4, comprenant en outre :
une borne de signal d'entrée (B) ;
une borne de signal de sortie (C) ;
une borne d'entrée de polarisation continue (D) ;
une borne de référence de masse (A) ;
dans lequel ledit amplificateur est un circuit intégré monolithique et chacun desdits transistors est un transistor bipolaire NPN réalisé au sein de la même tranche de circuit intégré monolithique ; et
dans lequel ladite tranche de circuit intégré comporte au moins une plage de connexion électrique destinée à constituer chacune desdites bornes, l'une au moins desdites bornes comprenant plusieurs desdites plages connectées électriquement en parallèle.
8. Un amplificateur radiofréquence selon les revendications 1, 2, 3 ou 4 comprenant en outre :
une borne de signal d'entrée (B) ;
une borne de signal de sortie (C) ;
une borne d'entrée de polarisation continue (D) ;
une borne de référence de masse (A) ;
dans lequel ledit amplificateur est un circuit intégré monolithique et chacun desdits transistors est un transistor bipolaire NPN réalisé au sein de la même tranche de circuit intégré monolithique ;
dans lequel ladite tranche de circuit intégré comporte au moins une plage de connexion électrique destinée à constituer chacune desdites bornes, l'une au moins desdites bornes comprenant plusieurs desdites plages connectées électriquement en parallèle ; et
dans lequel ledit amplificateur est logé dans un boîtier de circuit intégré "Micro-X" à quatre sorties ne ménageant que quatre points de connexion électrique extérieure.

Patentansprüche

1. Hochfrequenzverstärker (50) zum Verstärken von Signalen über 100 MHz, mit:
einem Hochfrequenz-Spannungsverstärkungstristor (Q4) zum Erzeugen einer Hochfrequenzspannung an einem Ausgang des Transistors, die proportional zu einem in Reihe zum Ausgang angelegten Hochfrequenzeingangsstrom ist,
einem einzelnen Hochfrequenz-Stromverstärkertransistor (Q2) mit nur einer einzigen Transistorverstärkerstufe mit einem operativ in Reihe zu dem Ausgang des Spannungsverstärkertransistors (Q4) und zu einem Stromverstärkungsgrad-Verstärken eines daran angelegten Hochfrequenz-Eingangssignals geschalteten Ausgang zum Steuern des an dem Hochfrequenz-Spannungsverstärkertransistor angelegten Stroms in Abhängigkeit von dem Hochfrequenz-Eingangssignal, wobei ein Hochfrequenz-Strom- und - Spannungsverstärkungsgrad-Verstärkersignal über die gemeinsam in Reihe geschalteten Ausgänge der Verstärkungstristoren mit einer Frequenz von mehr als 100 MHz bereitgestellt ist und
einer an jeden der Verstärkungstristoren und an einen gemeinsamen Gleichpegel-Voreinstelleingang angeschlossenen Pegelvoreinstellungseinrichtung zum Herstellen eines vom Signalpegel im wesentlichen unabhängigen Voreinstellungs-Ruhestroms innerhalb sowohl des Spannungs- als auch des Stromverstärkungstristors, wobei
die Pegelvoreinstellungseinrichtung wenigstens einen ersten Transistor (Q1) aufweist, und
der Hochfrequenz-Stromverstärkertransistor (Q2) in einer Stromspiegelkonfiguration zum ersten Transistor (Q1) geschaltet ist, wobei die Pegelvoreinstellungseinrichtung wenigstens eine Diode (Q3) und einen Widerstand (54, R3), die in Reihe zum ersten Transistor (Q1) geschaltet sind, aufweist, um daran einen Voreinstellstrom derart anzulegen, daß der durch die Pegelvoreinstellungseinrichtung dem Hochfrequenz-Stromverstärkertransistor (Q2) zugeführte Voreinstellungsstrom ausreicht, das Kollektor-Basis-Potential des Stromverstärkertransistors soweit über null anzuheben, daß ein Betrieb bei Frequen-



zen über 100 MHz sichergestellt ist.

2. Hochfrequenzverstärker nach Anspruch 1, wobei die Diodo einen Transistor (Q3) mit einer an den Kollektor an einem mit dem gemeinsamen Gleichpegel-Voreinstellungseingang verbundenen Knotenpunkt gekoppelten Basis aufweist, wobei der Knotenpunkt auch direkt mit dem Hochfrequenz-Spannungsverstärkungstransistor (Q4) verbunden ist.
3. Hochfrequenzverstärker nach Anspruch 1, wobei der erste Transistor (Q1) und der Hochfrequenz-Stromverstärkungstransistor (Q2) geometrisch so bemessene Strukturen haben, daß ein Stromvervielfachungsverhältnis von 1:M zwischen ihnen hergestellt ist, und ferner einen Entkopplungswiderstand (74) und einen Anpassungswiderstand (76) aufweisen, die in der Stromspiegelkonfiguration enthalten sind, wobei das Verhältnis zwischen dem Entkopplungswiderstand und dem Anpassungswiderstand gleich M:1 ist, so daß ein Gleichpegel-Stromverhältnis von 1:M zwischen dem ersten Transistor und dem Hochfrequenz-Stromverstärkungstransistor in Gegenwart des Entkopplungswiderstandes erhalten ist.
4. Hochfrequenzverstärker nach Anspruch 1, wobei der Hochfrequenz-Spannungs- und -Stromverstärkungstransistor gemeinsam ein Wechselstrom-Ausgangssignal bereitstellen, welches in Bezug auf ein Wechselstrom-Eingangssignal invertiert oder um 180° außer Phase ist.
5. Hochfrequenzverstärker nach Anspruch 1, 2, 3 oder 4, wobei der Verstärker ein monolithisch integrierter Schaltkreis ist, der von einem Halbleitersubstrat vom P-Typ als Ausgangsmaterial hergestellt ist.
6. Hochfrequenzverstärker nach Anspruch 1, 2, 3, oder 4, wobei der Verstärker ein monolithisch integrierter Schaltkreis ist und jeder der Transistoren ein bipolarer NPN-Transistor ist, der in demselben monolithisch integrierten Schaltkreis-Wafer hergestellt ist.
7. Hochfrequenzverstärker nach Anspruch 1, 2, 3 oder 4, ferner mit:
 - einem Eingangssignalanschluß (B),
 - einem Ausgangssignalanschluß (C),
 - einem Gleichpegel-Voreinstellungseingangsanschluß (D),
 - einem Erdreferenzanschluß (A),
 wobei der Verstärker ein monolithisch integrierter Schaltkreis ist und jeder der Transistoren ein bipolarer NPN-Transistor ist, der in demselben monolithisch integrierten Schaltkreis-Wafer hergestellt ist, und
 - wobei der integrierte Schaltkreis-Wafer wenigstens einen als jeder der genannten Anschlüsse dienenden elektrischen Anschlußbereich aufweist und wobei wenigstens einer der Anschlüsse mehrere solcher elektrisch parallel geschalteter Bereiche aufweist.
8. Hochfrequenzverstärker nach Anspruch 1, 2, 3 oder 4, ferner mit:
 - einem Eingangssignalanschluß (B),
 - einem Ausgangssignalanschluß (C),
 - einem Gleichpegel-Voreinstellungseingangsanschluß (D),
 - einem Erdreferenzanschluß (A),
 wobei der Verstärker ein monolithisch integrierter Schaltkreis ist und jeder der Transistoren ein bipolarer NPN-Transistor ist, der in demselben monolithisch integrierten Schaltkreis-Wafer hergestellt ist,
 - wobei der integrierte Schaltkreis-Wafer wenigstens einen als jeder der genannten Anschlüsse dienenden elektrischen Anschlußbereich aufweist und wobei wenigstens einer der Anschlüsse mehrere solcher elektrisch parallel geschalteter Bereiche aufweist, und
 - wobei der Verstärker in eine vier Leitungen aufweisende integrierte Mikro-X-Schaltkreis-Baueinheit, die nur vier externe elektrische Anschlußpunkte bereitstellt, gepackt ist.

